

November 1988 Revised November 1999

74AC20 **Dual 4-Input NAND Gate**

General Description

The AC20 contains four 4-input NAND gates.

Features

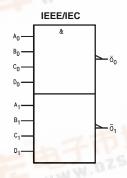
- I_{CC} reduced by 50%
- Outputs source/sink 24 mA

Ordering Code:

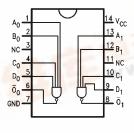
ı		T						
ı	Order Number	Package Number	Package Description					
ı	74AC20SC	M14A	14-Lead Small Outline Integrated Circuit (SOIC), JEDEC MS-120, 0.150" Narrow Body					
ı	74AC20SJ	M14D	14-Lead Small Outline Package (SOP), EIAJ TYPE II, 5.3mm Wide					
	74AC20MTC	MTC14	14-Lead Thin Shrink Small Outline Package (TSSOP), JEDEC MO-153, 4.4mm Wide					
ı	74AC20PC	N14A	14-Lead Plastic Dual-In-Line Package (PDIP), JEDEC MS-001, 0.300" Wide					

Device also available in Tape and Reel. Specify by appending suffix letter "X" to the ordering code.

Logic Symbol



Connection Diagram



Pin Descriptions

Pin Names	Description		
A _n , B _n , C _n , D _n	Inputs		
Ō _n	Outputs		

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Absolute Maximum Ratings(Note 1)

Recommended Operating Conditions

DC Input Voltage (V_I) $-0.5 \text{V to V}_{\text{CC}} + 0.5 \text{V}$

DC Output Diode Current (I_{OK})

 $\begin{aligned} \text{V}_{\text{O}} &= -0.5 \text{V} & -20 \text{ mA} \\ \text{V}_{\text{O}} &= \text{V}_{\text{CC}} + 0.5 \text{V} & +20 \text{ mA} \end{aligned}$

DC Output Voltage (V_O) -0.5V to $V_{CC} + 0.5V$

DC Output Source

or Sink Current (I $_{\rm O}$) \pm 50 mA

DC V_{CC} or Ground Current

per Output Pin (I_{CC} or I_{GND}) \pm 50 mA

Storage Temperature (T_{STG}) $-65^{\circ}C$ to $+150^{\circ}C$

Junction Temperature (T_J)

PDIP 140°C

 V_{IN} from 30% to 70% of V_{CC} V_{CC} @ 3.3V, 4.5V, 5.5V

Note 1: Absolute maximum ratings are those values beyond which damage to the device may occur. The databook specifications should be met, without exception, to ensure that the system design is reliable over its power supply, temperature, and output/input loading variables. Fairchild does not recommend operation of FACT™ circuits outside databook specifications.

DC Electrical Characteristics

Symbol	Parameter	v _{cc}	$T_A = +25^{\circ}C$		$T_A = -40^{\circ}C \text{ to } +85^{\circ}C$	Units	Conditions	
Symbol	raiametei	(V)	Тур	Typ Guaranteed Limits		Oilles	Conditions	
V _{IH}	Minimum HIGH Level	3.0	1.5	2.1 2.1			V _{OUT} = 0.1V	
	Input Voltage	4.5	2.25	3.15	3.15	V	or V _{CC} – 0.1V	
		5.5	2.75	3.85	3.85			
V _{IL}	Maximum LOW Level	3.0	1.5	0.9	0.9		V _{OUT} = 0.1V	
	Input Voltage	4.5	2.25	1.35	1.35	V	or V _{CC} – 0.1V	
		5.5	2.75	1.65	1.65			
V _{OH}	Minimum HIGH Level	3.0	2.99	2.9	2.9			
	Output Voltage	4.5	4.49	4.4	4.4	V	$I_{OUT} = -50 \ \mu A$	
		5.5	5.49	5.4	5.4			
							$V_{IN} = V_{IL}$ or V_{IH}	
		3.0		2.56	2.46		$I_{OH} = -12 \text{ mA}$	
		4.5		3.86	3.76	V	$I_{OH} = -24 \text{ mA}$	
		5.5		4.86	4.76		$I_{OH} = -24 \text{ mA (Note 2)}$	
V _{OL}	Maximum LOW Level	3.0	0.002	0.1	0.1			
	Output Voltage	4.5	0.001	0.1	0.1	V	$I_{OUT} = 50 \ \mu A$	
		5.5	0.001	0.1	0.1			
							$V_{IN} = V_{IL}$ or V_{IH}	
		3.0		0.36	0.44		$I_{OL} = 12 \text{ mA}$	
		4.5		0.36	0.44	V	$I_{OL} = 24 \text{ mA}$	
		5.5		0.36	0.44		$I_{OL} = 24 \text{ mA (Note 2)}$	
I _{IN}	Maximum Input	5.5		± 0.1	± 1.0	μА	$V_I = V_{CC}$, GND	
(Note 4)	Leakage Current	5.5		± 0.1	± 1.0	μΑ	VI = VCC, GIND	
I _{OLD}	Minimum Dynamic	5.5			75	mA	V _{OLD} = 1.65V Max	
I _{OHD}	Output Current (Note 3)	5.5			-75	mA	V _{OHD} = 3.85V Min	
I _{CC}	Maximum Quiescent	5.5		2.0	20.0	μΑ	$V_{IN} = V_{CC}$	
(Note 4)	Supply Current						or GND	

Note 2: All outputs loaded; thresholds on input associated with output under test.

Note 3: Maximum test duration 2.0 ms, one output loaded at a time.

Note 4: I_{IN} and I_{CC} @ 3.0V are guaranteed to be less than or equal to the respective limit @ 5.5V V_{CC} .

AC Electrical Characteristics

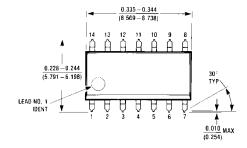
Symbol	Parameter	V _{CC} (V)	$T_A = +25$ °C $C_L = 50 \text{ pF}$			$T_A = -40$ °C to +85°C $C_L = 50$ pF		Units
		(Note 5)	Min	Тур	Max	Min	Max	
t _{PLH}	Propagation Delay	3.3	2.0	6.0	8.5	1.5	10.0	
		5.0	1.5	5.0	7.0	1.0	8.0	ns
t _{PHL}	Propagation Delay	3.3	1.5	5.0	7.0	1.0	9.0	no
		5.0	1.5	4.0	6.0	1.0	7.0	ns

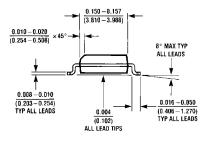
Note 5: Voltage Range 3.3 is 3.3V ± 0.3V Voltage Range 5.0 is 5.0V ± 0.5V

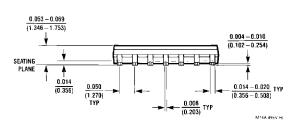
Capacitance

Symbol	Parameter	Тур	Units	Conditions
C _{IN}	Input Capacitance	4.5	pF	V _{CC} = OPEN
C _{PD}	Power Dissipation Capacitance	40.0	pF	$V_{CC} = 5.0V$

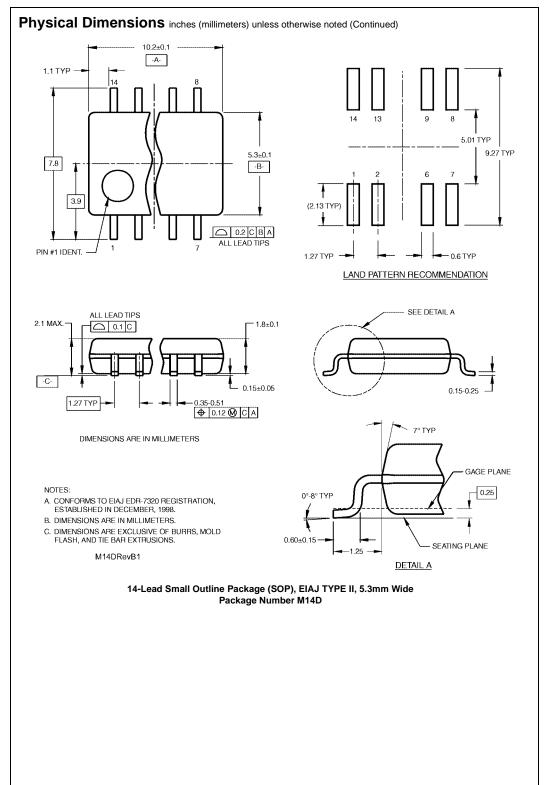
Physical Dimensions inches (millimeters) unless otherwise noted



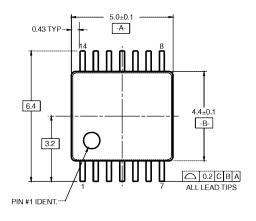


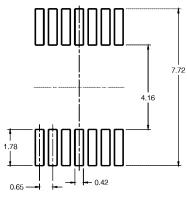


14-Lead Small Outline Integrated Circuit (SOIC), JEDEC MS-120, 0.150" Narrow Body Package Number M14A

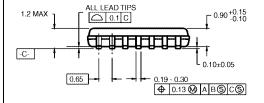


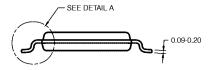
Physical Dimensions inches (millimeters) unless otherwise noted (Continued)





LAND PATTERN RECOMMENDATION

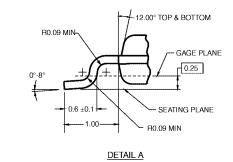




NOTES:

- A. CONFORMS TO JEDEC REGISTRATION MO-153, VARIATION AB, REF NOTE 6, DATE 7/93.
- B. DIMENSIONS ARE IN MILLIMETERS.
- C. DIMENSIONS ARE EXCLUSIVE OF BURRS, MOLD FLASH, AND TIE BAR EXTRUSIONS.
- D. DIMENSIONS AND TOLERANCES PER ANSI Y14.5M, 1982.

MTC14RevC3



14-Lead Thin Shrink Small Outline Package (TSSOP), JEDEC MO-153, 4.4mm Wide Package Number MTC14

14-Lead Plastic Dual-In-Line Package (PDIP), JEDEC MS-001, 0.300" Wide Package Number N14A

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